

Notice of References Cited	Application/Control No. 10/748,154		Applicant(s)/Patent Under Reexamination SIEVER, DAVID	
	Examiner Erik J. Bustamante		Art Unit 3766	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,709,645	01-1998	Siever, David	600/27
*	B	US-4,315,502	02-1982	Gorges, Denis E.	600/27
*	C	US-5,137,018	08-1992	Chuprikov et al.	607/45
*	D	US-6,875,167 B2	04-2005	Yoon, James	600/27
*	E	US-3,893,450	07-1975	Ertl, John P.	600/544
*	F	US-5,241,967	09-1993	Yasushi et al.	600/545
*	G	US-5,562,719	10-1996	Lopez-Claros, Marcelo E.	607/88
*	H	US-3,893,450	07-1975	Ertl, John P.	600/544
*	I	US-4,777,937	10-1988	Rush et al.	600/27
*	J	US-6,488,698 B1	12-2002	Hyman, Henry H.	607/91
*	K	US-5,306,228	04-1994	Rubins, Tye	600/27
*	L	US-5,954,629	09-1999	Yanagidaira et al.	600/27
*	M	US-5,219,322	06-1993	Weathers, Lawrence R.	600/27

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.